

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Nobuo Imamura et al. Art Unit : Unknown
Serial No. : 10/566,921 Examiner : Unknown
Filed : January 31, 2006 Conf. No. : 1169
Title : CHIP REMOVAL METHOD AND CHIP REMOVAL AIR BLOW NOZZLE

MAIL STOP AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the reference listed on the attached PTO-1449 form. A copy of the reference is enclosed. Also, a copy of an Office Action from the Japanese Patent Office in a counterpart application also is enclosed.

English-language translations are enclosed for the Japanese Office Action and for the listed reference.

This statement is being filed before the receipt of a first Office Action on the merits. I, the undersigned, hereby certify the item of information listed in this statement was cited in the enclosed Japanese Office Action in a counterpart application, the communication being dated January 9, 2007, which is not more than three months prior to the filing date of this statement.

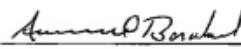
Applicant : Nobuo Inamura et al.
Serial No. : 10/566,921
Filed : January 31, 2006
Page : 2 of 2

Attorney's Docket No.: 15682-017US1 / OSP-19442

Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: 3/29/07



Samuel Borodach
Reg. No. 38,388

Fish & Richardson P.C.
Citigroup Center
52nd Floor
153 East 53rd Street
New York, New York 10022-4611
Telephone: (212) 765-5070
Facsimile: (212) 258-2291

30334188.doc

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 15682-017US1	Application No. 10/566,921
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant: Nobuo Imamura et al.	
		Filing Date January 31, 2006	Group Art Unit

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Yes No
	AL	2002-361192	12/17/2002	Japan			X
	AM						
	AN						
	AO						
	AP						

Other Documents (include Author, Title, Date, and Place of Publication)							
Examiner Initial	Desig. ID	Document					
	AQ						
	AR						
	AS						
	AT						

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	